

<b>Notice of References Cited</b>	Application/Control No. 10/743,638		Applicant(s)/Patent Under Reexamination NOH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0102466	08-2002	Hwang et al.	429/329
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-319430	10-2002	JP	Sasaki	
	O				Patent and translation	
	P	JP 2002-237331	08-2002	JP	Sano et al.	
	Q				Patent and translation	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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